


<b>Search Notes</b>  	<b>Application/Control No.</b>  10501566	<b>Applicant(s)/Patent Under Reexamination</b>  UNO ET AL.
	<b>Examiner</b>  JON M LOCKARD	<b>Art Unit</b>  1647

SEARCHED			
Class	Subclass	Date	Examiner
NONE		2/7/08	JML

SEARCH NOTES		
Search Notes	Date	Examiner
STIC Search of SEQ ID NO:1. See sequence search results in SCORE.	1/22/08	JML
EAST (USPAT, US-PGPUB, EPO, DERWENT): See attached search history.	2/7/08	JML
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS): See attached search history.	2/7/08	JML
PALM: Inventor search.	2/7/08	JML
EAST (USPAT, US-PGPUB, EPO, DERWENT): See attached search history.	10/29/08	JML
PALM: Inventor search.	10/29/08	JML
STIC Search of SEQ ID NO:1. See sequence search results in SCORE.	6/8/09	JML
EAST (USPAT, US-PGPUB, EPO, DERWENT): See attached search history.	6/18/09	JML
PALM: Inventor search.	6/18/09	JML
Consulted with R. Wax Re. New Matter	6/16/09	JML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	STIC Search of SEQ ID NO:1. See sequence search results in SCORE.	11/23/09	JML
	EAST (USPAT, UPAD): See attached search history.	11/30/09	JML
	PALM: Inventor search.	11/30/09	JML

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